Supporting Information for

## Controllable incorporation of 1,2,4-triazolate into cluster-based metal-chalcogenide frameworks

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## **Experimental Section:**

**Chemicals and Materials.** Indium nitrate hydrate  $(In(NO_3)_3 \cdot 4.5H_2O_1) \ge 99.5\%)$ , thiourea (CH<sub>4</sub>N<sub>2</sub>S, 99%), sulfide powder (S,  $\ge 99.5\%$ ), acetonitrile (C<sub>2</sub>H<sub>3</sub>N,  $\ge 98\%$ ), 1,2,4-triazole (C<sub>2</sub>H<sub>3</sub>N<sub>3</sub>, 98%), 1,5-diazabicyclo[4.3.0]non-5-ene (DBN, 98%), 1,8-diazabicyclo [5.4.0]undec-7-ene (DBU), 1-(2-aminoethyl)piperazine (AEP, >99.0%), 2-amino-1-butanol(AB, 98%), N,N-dimethylformamide (DMF,  $\ge 98\%$ ) were all used without any further purification.

Synthesis of SCTF-1. A mixture of  $In(NO_3)_3$ ·4.5H<sub>2</sub>O (124 mg, 1 mmol), sulfide powder (96 mg, 3 mmol), 1,2,4-triazole (105 mg, 1.5 mmol), DMF (2 mL), AB (2 mL), DBN (2 mL) were stirred in a 23-mL Teflon-lined stainless steel autoclave for half an hour. The vessel was sealed and heated at 180 °C for 7 days, then the autoclave was cooled to room temperature. After the raw products were washed by absolute ethyl alcohol several times, a large number of colorless crystals were obtained. The phase purity was identified by powder X-ray diffraction measurements.

Synthesis of SCTF-2. A mixture of  $In(NO_3)_3 \cdot 4.5H_2O$  (124 mg, 1 mmol), thiourea (76 mg, 1 mmol), 1,2,4-triazole (75 mg, 1 mmol), acetonitrile (1 mL), AEP (1 mL), DBU (3 mL) were stirred in a 23-mL Teflon-lined stainless steel autoclave for half an hour. The vessel was sealed and heated at 150 °C for 7 days, then the autoclave was cooled to room temperature. After the raw products were washed by absolute ethyl alcohol several times, a large number of yellowish crystals were obtained. The phase purity was identified by powder X-ray diffraction measurements.

Single Crystal X-ray Diffraction (SCXRD). Single-crystal X-ray diffraction measurements were performed on Photon II CPAD diffractometer controlled using graphite mono-chromated Mo-K $\alpha$  ( $\lambda$  =0.71073 Å) radiation at 120 K. The structure was solved by direct method using SHELXS-2014 and the refinements against all reflections of the compound were performed using SHELXL-2014.

Powder X-ray Diffraction (PXRD). PXRD data were collected on a desktop

diffractometer (D2 PHASER, Bruker, Germany) using Cu-K $\alpha$  ( $\lambda$  = 1.54184 Å) radiation operated at 30 kV and 10 mA. The samples were ground into fine powders for several minutes before the test.

**Elemental Analysis.** Energy dispersive spectroscopy (EDS) analysis was performed on scanning electron microscope (SEM) equipped with energy dispersive spectroscopy (EDS) detector. An accelerating voltage of 25 kV and 40 s accumulation time were applied. Elemental analysis of C, H, and N was performed on VARIDEL III elemental analyzer. (**SCTF-1**, *Calcd*.: C,19.66; N, 7.26; H, 2.55 *wt%*; *Found*: C, 19.27; N, 7.31; H, 3.42 *wt%*; and **SCTF-2** *Calcd*.: C, 18.76; N, 7.69; H, 2.41 *wt%*; *Found*: C, 22.10; N, 7.57; H, 3.78 *wt%*).

**Thermogravimetric (TG) Measurement.** A Shimadzu TGA-50 thermal analyzer was used to measure the TG curve by heating the sample from room temperature to 800 °C with heating rate of 10 °C /min under  $N_2$  flow.

**Fourier-Transform Infrared Absorption.** Fourier transform-Infrared spectral analysis was performed on a Thermo Nicolet Avatar 6700 FT-IR spectrometer with cesium iodide optics allowing the instrument to observe from 600-4000 cm<sup>-1</sup>.

**UV-Vis Absorption.** Room-temperature solid-state UV-Vis diffusion reflectance spectra of **SCTF-1** and **SCTF-2** samples were measured on a SHIMADZU UV-3600 UV-Vis-NIR spectrophotometer coupled with an integrating sphere by using BaSO<sub>4</sub> powder as the reflectance reference. The absorption spectra were calculated from reflectance spectra by using the Kubelka-Munk function:  $F(R) = \alpha/S = (1-R)^2/2R$ , where R,  $\alpha$ , and S are the reflection, the absorption and the scattering coefficient, respectively. In order to determine the band edge of the direct-gap semiconductor, the relation between the absorption coefficients ( $\alpha$ ) and the incident photon energy (hv) is exhibited as  $\alpha hv = A(hv-E_g)^{1/2}$ , where A is a constant that relates to the effective masses associated with the valence and conduction bands, and  $E_g$  is the optical transition gap of the solid material. The band gap of the obtained samples can be

determined from the Tauc plot with  $[F(R)*hv]^2$  vs. hv by extrapolating the linear region to the abscissa.

Compound	SCTF-1	SCTF-2
Crystal system	monoclinic	orthorhombic
Space group	$P2_{1}/c$	Pbca
Ζ	4	8
<i>a</i> (Å)	32.120(4)	20.887(4)
<i>b</i> (Å)	20.820(2)	22.592(5)
<i>c</i> (Å)	22.273(2)	33.244(7)
α (deg.)	90	90.00(3)
$\beta$ (deg.)	94.085(3)	90.00(3)
γ (deg.)	90	90.00(3)
$V(Å^3)$	14857(3)	15687(6)
GOF on $F^2$	1.070	1.150
$R_1, wR_2 (I > 2\sigma(I))$	0.0952,0.2503	0.0274, 0.0504
$R_1$ , $wR_2$ (all data)	0.1159,0.2646	0.0323, 0.0517

 Table S1. Crystallographic data and structure refinement parameters for SCTF-1 and

 SCTF-2.

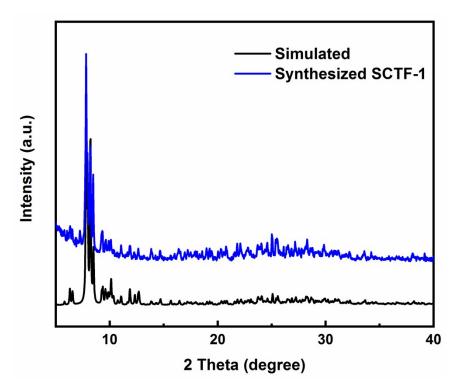
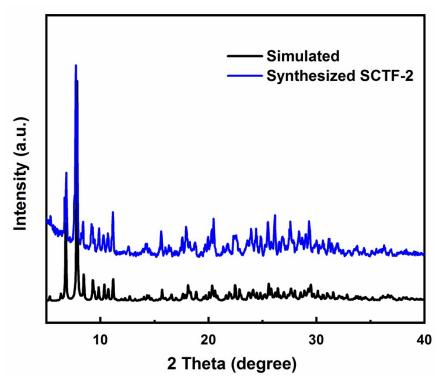
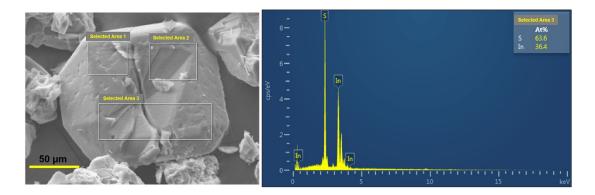


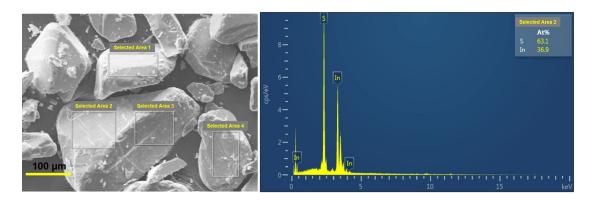
Figure S1. Powder X-ray diffraction (PXRD) pattern of as-synthesized SCTF-1 and its simulated one.



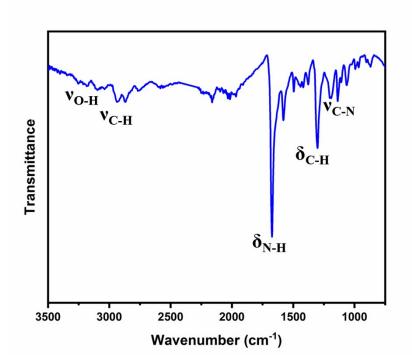
**Figure S2.** Powder X-ray diffraction (PXRD) pattern of as-synthesized **SCTF-2** and its simulated one.



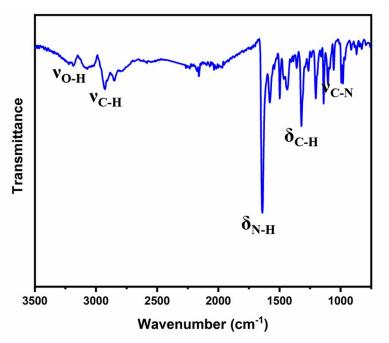
**Figure S3**. Left: SEM image of as-synthesized SCTF-1 crystals. Right: energy dispersive spectroscopy (EDS) of SCTF-1. The results clearly confirmed the presence of In and S elements, and the measured molar ratio of S/In is 1.747, which is consistent with the theoretical value of 1.75.



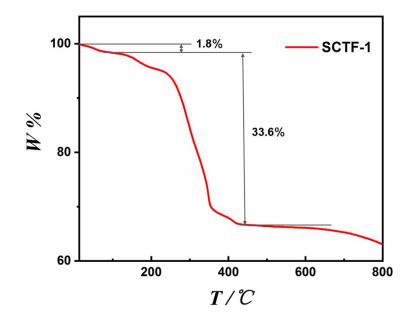
**Figure S4**. Left: SEM image of as-synthesized SCTF-2 crystals. Right: energy dispersive spectroscopy (EDS) of SCTF-2. The results clearly confirmed the presence of In and S elements, and the measured molar ratio of S/In is 1.71, which is consistent with the theoretical value of 1.70.



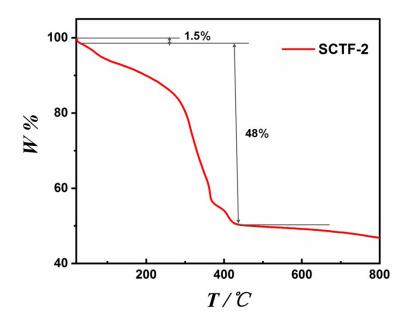
**Figure S5**. FT-IR spectrum of **SCTF-1**. The bands of IR at about 3235cm<sup>-1</sup> belong to the stretching vibration of the O-H. The IR bands at 2930 cm<sup>-1</sup>, 2848 cm<sup>-1</sup> and 1310 cm<sup>-1</sup> belong to the stretching vibration and bending vibration of the C-H of organic amines. The IR bands at 1650 cm<sup>-1</sup> indicate the presence of N-H group. The broad vibration bands of IR at 1310 cm<sup>-1</sup>, 1208 cm<sup>-1</sup> and 1102 cm<sup>-1</sup> belong to the stretching vibration of C-N.



**Figure S6**. FT-IR spectrum of **SCTF-2**. Important data (cm<sup>-1</sup>): 3228(w), 2935(w), 2827(w), 1643(s), 1442(m), 1228(m), 1105(m).



**Figure S7.** Thermal gravimetric (TG) measurement of **SCTF-1**. The initial gradual weight loss of 1.8% between 30-100 °C could be attributed to loss of moisture and solvent adsorbed on the surface of **SCTF-1**. An abrupt weight loss of 33.6% between 100-400 °C is attributed to the carbonization of template and TZ ligands.



**Figure S8.** Thermal gravimetric (TG) measurement of **SCTF-2**. The initial gradual weight loss of 1.5% between 30-100 °C could be attributed to loss of moisture and solvent adsorbed on the surface of **SCTF-2**. An abrupt weight loss of 48% between 100-400 °C is attributed to the carbonization of template and TZ ligands.

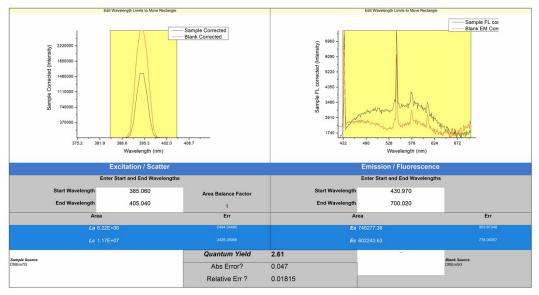


Figure S9. PL quantum yield of SCTF-1.

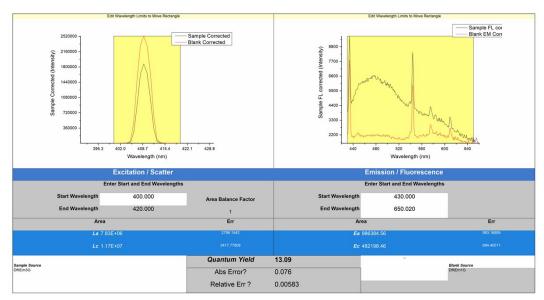


Figure S10. PL quantum yield of SCTF-2.

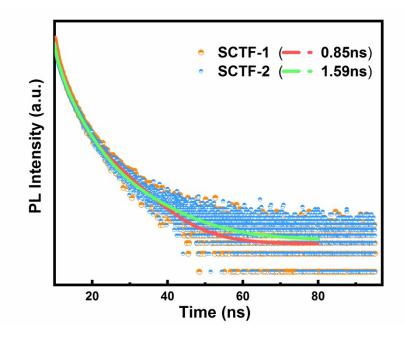


Figure S11. The room-temperature PL decay curves of SCTF-1 and SCTF-2.

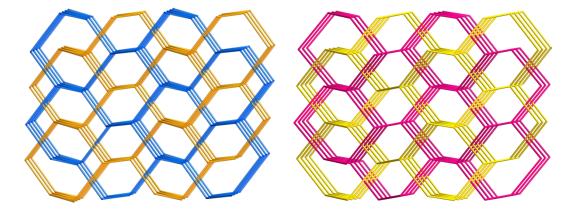


Figure S12. Double-interpenetrated *dia* topology of SCTF-1 and SCTF-2 viewed along b axis. (left: SCTF-1, right: SCTF-2).